

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057

 Telephone:
 +86 (0) 755 2601 2053

 Fax:
 +86 (0) 755 2671 0594

 Email:
 ee.shenzhen@sgs.com

Report No.: SZEM180700654901 Page: 1 of 36

FCC TEST REPORT

Application No:	SZEM1807006549RG
Applicant:	Huawei Technologies Co., Ltd.
Address of Applicant	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Manufacturer:	Huawei Technologies Co., Ltd.
Address of Manufacturer	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Product Name:	Smart Phone
Model No.(EUT):	HMA-L29, HMA-L09
Trade Mark:	HUAWEI
FCC ID:	QISHMA-LX9
Standards:	47 CFR Part 2
	47 CFR Part 22 subpart H
	47 CFR Part 24 subpart E
	47 CFR Part 27 subpart C
	47 CFR Part 90 subpart R
Test Method:	FCC KDB 971168 D01 Power Meas License Digital Systems V03r01
	TIA-603-E 2016
Date of Receipt:	2018-07-10
Date of Test:	2018-07-11 to 2018-08-20
Date of Issue:	2018-09-03
Test Result:	PASS *

In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:

Derde young

Derek Yang Wireless Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions.Terms-e-Document.aspx. Attention is drawn to the limitation of liability, indemnification is advised befined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgrey or falsification of the content or appearance of this document fu and wiful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 2 of 36

1 Version

Revision Record							
Version Chapter Date Modifier Remark							
01		2018-09-03		Original			

Authorized for issue by:		
Tested By	Mike Mu	
		2018-09-03
	(Mike Hu) /Project Engineer	Date
Checked By	David Chen	
		2018-09-03
	(David Chen) /Reviewer	Date



Report No.: SZEM180700654901 Page: 3 of 36

Page

Content

1	VER	SION	2
2	TES	T SUMMARY	5
	2.1	GSM850/UMTS BAND 5<E BAND 5 / 26	5
	2.2	GSM1900/UMTS BAND 2 /LTE BAND 2	5
	2.3	UMTS BAND 4 /LTE BAND 4	6
	2.4	LTE BAND 7/38/41	6
	2.5	LTE BAND 12/17	7
	2.6	LTE BAND 26	7
3	GEN	IERAL INFORMATION	9
	3.1	CLIENT INFORMATION	9
	3.2	GENERAL DESCRIPTION OF EUT	9
	3.3	TEST MODE	10
	3.4	TEST ENVIRONMENT	11
	3.5	TEST FREQUENCIES	11
	3.6	TEST LOCATION	20
	3.7	TEST FACILITY	20
	3.8	DEVIATION FROM STANDARDS	20
	3.9	ABNORMALITIES FROM STANDARD CONDITIONS	20
	3.10	OTHER INFORMATION REQUESTED BY THE CUSTOMER	21
	3.11	TECHNICAL SPECIFICATION	21
4	DES	CRIPTION OF TESTS	24
	4.1	CONDUCTED OUTPUT POWER	24
	4.2	EFFECTIVE (ISOTROPIC) RADIATED POWER OF TRANSMITTER	24
	4.3	OCCUPIED BANDWIDTH	25
	4.4	BAND EDGE AT ANTENNA TERMINALS	26
	4.5	Spurious And Harmonic Emissions at Antenna Termina	L 26
	4.6	PEAK-AVERAGE RATIO	27
	4.7	FIELD STRENGTH OF SPURIOUS RADIATION	27
	4.8	FREQUENCY STABILITY / TEMPERATURE VARIATION	28
	4.9	TEST SETUPS	30
	Test	Setup 1	30



Report No.: SZEM180700654901 Page: 4 of 36

	Test Setup 2	30
	Test Setup 3	31
	Test Setup 4	31
4	4.10 TEST CONDITIONS	32
5	MAIN TEST INSTRUMENTS	34
6	MEASUREMENT UNCERTAINTY	36
7	PHOTOGRAPHS - EUT CONSTRUCTIONAL DETAILS	36



Report No.: SZEM180700654901 Page: 5 of 36

2 Test Summary

2.1 GSM850/UMTS BAND 5<E BAND 5 / 26

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913	FCC: ERP ≤ 7 W	Section 1 of Appendix B	Pass
Peak-Average Ratio		Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §2 2.917	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §2 2.917	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §22.917	FCC: ≤ -13 dBm/100 kHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §22.355	≤ ±2.5ppm.	Section 8 of Appendix B	Pass
NOTE: For the verdic	t, the "N/A" denotes	s "not applicable", the "N/T" denotes "not tes	sted".	

2.2 GSM1900/UMTS BAND 2 /LTE BAND 2

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	EIRP ≤ 2 W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§2.1046, §24.232	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §24.238	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §24.238	≤ -13 dBm/1 MHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §24.238	≤ -13 dBm/1 MHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §24.235	≤ ±2.5 ppm.	Section 8 of Appendix B	Pass



Report No.: SZEM180700654901 Page: 6 of 36

Test Item	FCC Rule No.	Requirements	Test Result	Verdict		
NOTE: For the verdic	NOTE: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".					

2.3 UMTS BAND 4 /LTE BAND 4

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(d)	EIRP ≤ 1 W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§2.1046, §27.50(d)	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(h)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(h)	 ≤ -13 dBm/1 MHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges. 	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(h)	≤ -13 dBm/1 MHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	≤ ±2.5 ppm.	Section 8 of Appendix B	Pass
NOTE: For the verdic	ct, the "N/A" denotes	s "not applicable", the "N/T" denotes "not te	ested".	

2.4 LTE BAND 7/38/41

Z.4 LIE DAND	7/30/41			
Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP ≤ 2W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§27.50(a)	≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(m4)	For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.	Section 5 of Appendix B	Pass



Report No.: SZEM180700654901 Page: 7 of 36

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	25 dBm/ 1 MHz 9 kHz 95 MHz XMHz 10 th harmonics X=Max [6MHz, EBW]	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	25 dBm/ 1 MHz 9 kHz 95 MHz XMHz 10 th harmonics X=Max (6MHz, EBW)	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B	Pass
NOTE: For the verdic	ct, the "N/A" denotes	s "not applicable", the "N/T" denotes "not t	ested".	

2.5 LTE BAND 12/17

Test Item	FCC Rule No	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§27.50(c)	FCC: ERP ≤ 3 W.	Section 1 of Appendix B	Pass
Peak-Average Ratio	§2.1046, §27.50(c)	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, Ş2 7.53(g)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, Ş2 7.53(g)	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(g)	FCC: ≤ -13 dBm/100 kHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	≤ ±2.5ppm.	Section 8 of Appendix B	Pass
NOTE: For the verdi	ct, the "N/A" denote	s "not applicable", the "N/T" denotes "not te	ested".	

2.6 LTE BAND 26

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Transmitter Conducted Power Output	§2.1046, §90.635	< 100 W.	Section 1 of Appendix B	PASS
Peak-Average Ratio		FCC: Limit≤13 dB	Section 2 of Appendix B	N/T
Modulation	§2.1047	Digital modulation	Section 3 of	PASS



Report No.: SZEM180700654901 Page: 8 of 36

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Characteristics			Appendix B	
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	PASS
Emission Mask	§2.1051 § 90.210	For any frequency removed from the EA licensee's frequency block by up to and including 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least 116 Log10(f/6.1) decibels or 50+10Log10(P) decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 12.5 kHz.	Section 5 of Appendix B	PASS
Spurious Emission at Antenna Terminals	§2.1051, §90.691	< 43 + 10Log10(P[Watts]) for all out-of- band emissions	Section 6 of Appendix B	PASS
Field Strength of Spurious Radiation	§2.1053, §90.691	< 43 + 10Log10(P[Watts]) for all out-of- band emissions	Section 7 of Appendix B	PASS
Frequency Stability	§2.1055, §90.213	< ±2.5ppm.	Section 8 of Appendix B	PASS
,	Ŭ	otes "not applicable", the "N/T" denotes "not		

Remark:

According to the declaration from the applicant, the differences between HMA-L29 and HMA-L09 are identical except for HMA-L09 support single SIM card which deleted by software. Therefore we only test HMA-L29 in this report



Report No.: SZEM180700654901 Page: 9 of 36

3 General Information

3.1 Client Information

Applicant:	Huawei Technologies Co., Ltd.
Address of Applicant:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Manufacturer:	Huawei Technologies Co., Ltd.
Address of Manufacturer:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

3.2 General Description of EUT

Product Name:	Smart Phone
Model No.:	HMA-L29, HMA-L09
Trade Mark:	HUAWEI
Hardware Version:	HL1HIMAM
Software Version:	9.0.0.46(C432E55R1P7log)
Sample Type:	Portable Device
Antenna Type:	PIFA
	GSM850: -2.76dBi(Main Antenna); -11.05dBi (Second Antenna);
	GSM1900:-1.43dBi(Main Antenna); -4.93dBi (Second Antenna);
	WCDMA BAND II:-2.61dBi(Main Antenna); -3.51dBi (Second Antenna);
	WCDMA BAND VI:-0.284dBi(Main Antenna); -7.92dBi (Second Antenna);
	WCDMA BAND V:-3.41dBi(Main Antenna); -7.24dBi (Second Antenna);
	LTE BAND 2:-2.05dBi(Main Antenna); -3.42dBi (Second Antenna);
Antenna Gain:	LTE BAND 4:0.21dBi(Main Antenna); -8.12dBi (Second Antenna);
Antenna Gain.	LTE BAND 5:-2.66dBi(Main Antenna); -7.35dBi (Second Antenna);
	LTE BAND 7: 1.01dBi(Main Antenna); -3.36dBi (Second Antenna);
	LTE BAND12:-4.73dBi(Main Antenna); -7.43dBi (Second Antenna);
	LTE BAND17: -4.37dBi(Main Antenna); -7.57dBi (Second Antenna);
	LTE BAND26:-2.95dBi(Main Antenna); -7.04dBi (Second Antenna);
	LTE BAND38: 0.63dBi(Main Antenna); -2.81dBi (Second Antenna);
	LTE BAND41: 0.89dBi(Main Antenna); -3.61dBi (Second Antenna);
	Battery Model: HB436486ECW
	Rated capacity: 3900mAh
Power Supply	Nominal Voltage: +3.82V
	Charging Voltage: +4.40V
	Model: HW-050450B00
AC adaptor:	Manufacturer: Huawei Technologies Co., Ltd.
	Input: 100V-240V~50/60Hz, 0.75A

This document is issued by the Company subject to its General Conditions for Service printed ovenear, available on request or accessible at <u>intp://www.sds.com/entrems-and-Conditions.app</u> and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at <u>thtp://www.sds.com/entrems-and-Conditions.formation-conditions.formation-conditions.formation-conditions.formation-conditions.formation-conditions.formation-conditions.formation-conditions.formation-conditions.formation-conditions.formation-condited-formation-condited-formation-conditions.formation-conditions</u>



Report No.: SZEM180700654901 Page: 10 of 36

Output: 5V === 2A OR4.5V === 5A OR 5V === 4.5A Model: HW-050450E00 Manufacturer: Huawei Technologies Co., Ltd. Input: 100V-240V~50/60Hz, 0.75A
Output: 5V === 2A OR4.5V === 5A OR 5V === 4.5A Model: HW-050450U00 Manufacturer: Huawei Technologies Co., Ltd. Input: 100V-240V~50/60Hz, 0.75A
Output: 5V === 2A OR4.5V === 5A OR 5V === 4.5A Model: HW-050450A00 Manufacturer: Huawei Technologies Co., Ltd. Input: 100V-240V~50/60Hz, 0.75A
Output: 5V === 2A OR4.5V === 5A OR 5V === 4.5A Model: HW-050450E01 Manufacturer: Huawei Technologies Co., Ltd. Input: 100V-240V~50/60Hz, 0.75A
Output: 5V === 2A OR 9V === 2A

3.3 Test Mode

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation
GSM/TM2	GSM system, EGPRS, 8PSK modulation
UMTS/TM1	UMTS system, WCDMA, QPSK modulation
UMTS/TM2	UMTS system, WCDMA, 16QAM modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
LTE/TM3	LTE system, 64QAM modulation

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-en-Document.aspx, Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 11 of 36

3.4 Test Environment

Environment Parameter	Selected Values During Tests		
Relative Humidity	52%		
Atmospheric Pressure:	101.32 KPa		
Temperature	NT	25 °C	
	LV	3.6V	
Voltage:	NV	3.82V	
	HV	4.35V	

NOTE: LV= lower extreme test voltage; NV= nominal voltage

HV= upper extreme test voltage; NT= normal temperature

3.5 Test Frequencies

Test Mode	TX / RX	RF Channel			
Test Mode		Low (L)	Middle (M)	High (H)	
	тх	Channel 128	Channel 190	Channel 251	
COMPEO		824.2MHz	836.6 MHz	848.8 MHz	
GSM850	RX	Channel 128	Channel 190	Channel 251	
	ΓA	869.2 MHz	881.6 MHz	893.8 MHz	

Test Mode	TX / RX	RF Channel		
Test Mode		Low (L)	Middle (M)	High (H)
	TX	Channel 512	Channel 661	Channel 810
CSM1000		1850.2MHz	1880.0 MHz	1909.8 MHz
GSM1900 -	RX	Channel 512	Channel 661	Channel 810
	KΛ	1930.2 MHz	1960.0 MHz	1989.8 MHz

Test Mode	TX / RX	RF Channel		
Test Mode		Low (L)	Middle (M)	High (H)
	TV	Channel 4132	Channel 4182	Channel 4233
WCDMA	ТХ	826.4MHz	836.4 MHz	846.6 MHz
BAND V	DV	Channel 4357	Channel 4407	Channel 4458
	RX	871.4 MHz	881.4 MHz	891.6 MHz

Test Mode	TX / RX	RF Channel		
Test Mode		Low (L)	Middle (M)	High (H)
WCDMA	тх	Channel 1312	Channel 1413	Channel 1513
BAND IV		1712.4MHz	1732.6 MHz	1752.6 MHz

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-en-Document.aspx, Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 12 of 36

RX	Channel 1537	Channel 1638	Channel 1738
RA RA	2112.4 MHz	2132.6 MHz	2152.6 MHz

Test Mode	pde TX / RX RF Channel				
Test Mode		Low (L)	Middle (M)	High (H)	
	тх	Channel 9262	Channel 9400	Channel 9538	
WCDMA		1852.4 MHz	1880.0 MHz	1907.6 MHz	
BAND II	DV	Channel 9662	Channel 9800	Channel 9938	
	RX	1932.4 MHz	1960.0 MHz	1987.6 MHz	

Test Mode	Bandwidth	TX / RX		RF Channel	
Test Mode	Danuwiutii		Low (L)	Middle (M)	High (H)
		ТХ	Channel 18607	Channel 18900	Channel 19193
	1.4MHz	IA	1850.7 MHz	1880 MHz	1909.3 MHz
	1.4IVI⊓Z	RX	Channel 607	Channel 900	Channel 1193
		КЛ	1930.7 MHz	1960 MHz	1989.3 MHz
		ТХ	Channel 18615	Channel 18900	Channel 19185
	3MHz	IA	1851.5 MHz	1880 MHz	1908.5 MHz
	SIVINZ	RX	Channel 615	Channel 900	Channel 1185
		КЛ	1931.5 MHz	1960 MHz	1988.5 MHz
		ТХ	Channel 18625	Channel 18900	Channel 19175
	5MHz		1852.5 MHz	1880 MHz	1907.5 MHz
	SIVINZ	RX	Channel 625	Channel 900	Channel1175
LTE BAND 2			1932.5 MHz	1960 MHz	1987.5 MHz
LIE DAIND Z		ТХ	Channel 18650	Channel 18900	Channel 19150
	10MHz		1855 MHz	1880 MHz	1905 MHz
		DΥ	Channel 650	Channel 900	Channel 1150
		RX	1935 MHz	1960 MHz	1985 MHz
		ТХ	Channel 18675	Channel 18900	Channel 19125
	15MHz		1857.5 MHz	1880 MHz	1902.5 MHz
		RX	Channel 675	Channel 900	Channel 1125
		КЛ	1937.5 MHz	1960 MHz	1982.5 MHz
		ТХ	Channel 18700	Channel 18900	Channel 19100
	20MHz		1860 MHz	1880 MHz	1900 MHz
	2011112	RX	Channel 700	Channel 900	Channel 1100
		ΓΛ	1940 MHz	1960 MHz	1980 MHz



Report No.: SZEM180700654901 Page: 13 of 36

Test Made	Dondwidth	TX / RX		RF Channel	
Test Mode	Bandwidth	IX/RX	Low (L)	Middle (M)	High (H)
		ТХ	Channel 19957	Channel 20175	Channel 20393
	1.4MHz		1710.7 MHz	1732.5 MHz	1754.3 MHz
		RX	Channel 1975	Channel 2175	Channel 2375
		100	2112.5 MHz	2132.5MHz	2152.5 MHz
		ТХ	Channel 19965	Channel 20175	Channel 20385
	3MHz		1711.5 MHz	1732.5 MHz	1753.5 MHz
	011112	RX	Channel 2000	Channel 2175	Channel 2350
			2115 MHz	2132.5MHz	2150 MHz
		ТХ	Channel 19975	Channel 20175	Channel 20375
	5MHz	ТХ	1712.5 MHz	1732.5 MHz	1752.5 MHz
		RX	Channel 1975	Channel 2175	Channel 2375
LTE BAND 4			2112.5 MHz	2132.5MHz	2152.5 MHz
		ТΧ	Channel 20000	Channel 20175	Channel 20350
	10MHz		1715 MHz	1732.5 MHz	1750 MHz
	1011112	RX	Channel 2000	Channel 2175	Channel 2350
			2115 MHz	2132.5MHz	2150 MHz
		ТХ	Channel 20025	Channel 20175	Channel 20325
	15MHz		1717.5 MHz	1732.5 MHz	1747.5 MHz
	1011112	RX	Channel 2025	Channel 2175	Channel 2325
			2117.5 MHz	2132.5MHz	2147.5 MHz
		ТХ	Channel 20050	Channel 20175	Channel 20300
	20MHz		1720 MHz	1732.5 MHz	1745 MHz
	2010112	RX	Channel 2050	Channel 2175	Channel 2300
			2120 MHz	2132.5MHz	2145 MHz

Test Mode	Dondwidth	Bandwidth	TX / RX	RF Channel		
Test Mode	Danuwiuun		Low (L)	Middle (M)	High (H)	
		τv	Channel 20407	Channel 20525	Channel 20643	
	1.4MHz		824.7 MHz	836.5 MHz	848.3 MHz	
		RX	Channel 2407	Channel 20525	Channel 2643	
LTE BAND 5			869.7 MHz	881.5 MHz	893.3 MHz	
		ТХ	Channel 20415	Channel 20525	Channel 20635	
	3MHz RX	IX	825.5 MHz	836.5 MHz	847.5 MHz	
		RX	Channel 2415	Channel 20525	Channel 2635	

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions/Terms-en-Document.aspx. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 14 of 36

			870.5 MHz	881.5 MHz	892.5 MHz
		τv	Channel 20425	Channel 20525	Channel 20625
	5MHz	TX	826.5 MHz	836.5 MHz	846.5 MHz
		DV	Channel 2425	Channel 20525	Channel 2625
		RX	871.5 MHz	881.5 MHz	891.5 MHz
		TV	Channel 20450	Channel 20525	Channel 20600
	10MHz	TX	829 MHz	836.5 MHz	844 MHz
		RX -	Channel 2450	Channel 2525	Channel 2600
			874 MHz	881.5 MHz	889 MHz

Toot Mode	Dondwidth			RF Channel	
Test Mode	Bandwidth	TX / RX	Low (L)	Middle (M)	High (H)
		ТХ	Channel 20775	Channel 21100	Channel 21425
	5MHz		2502.5 MHz	2535 MHz	2567.5 MHz
	JIVII IZ	RX	Channel 2775	Channel 3100	Channel 5825
		ΓA	2622.5 MHz	2655 MHz	2687.5 MHz
		тх	Channel 20800	Channel 21100	Channel 21400
	10MHz		2505 MHz	2535 MHz	2565 MHz
		RX	Channel 2800	Channel 3100	Channel 3400
LTE BAND 7			2625 MHz	2655 MHz	2685 MHz
		ТΧ	Channel 20825	Channel 21100	Channel 21375
	15MHz		2507.5 MHz	2535 MHz	2562.5 MHz
	TOIVITIZ	DV	Channel 2825	Channel 3100	Channel 3375
		RX	2627.5 MHz	2655 MHz	2682.5 MHz
		ТХ	Channel 20850	Channel 21100	Channel 21350
	20MHz	IA	2510 MHz	2535 MHz	2560 MHz
		RX	Channel 2850	Channel 3100	Channel 3350
			2630 MHz	2655 MHz	2680 MHz

Test Mode	Dondwidth	Bandwidth TX / RX		RF Channel			
Test Mode	Danuwiutii		Low (L)	Middle (M)	High (H)		
		ТХ	Channel 23017	Channel 23095	Channel 23173		
	1.4MHz		699.7 MHz	707.5 MHz	715.3 MHz		
	I.4IVI⊓Z	RX	Channel 5017	Channel 5095	Channel 5173		
		RΛ	729.7 MHz	737.5 MHz	745.3 MHz		
LTE BAND12		ТХ	Channel 23025	Channel 23095	Channel 23165		
LIE BANDIZ	3MHz		700.5 MHz	707.5 MHz	714.5 MHz		
		υV	Channel 5025	Channel 5095	Channel 5165		
		RX	730.5 MHz	737.5 MHz	744.5 MHz		
		τv	Channel 23035	Channel 23095	Channel 23155		
		5MHz TX	701.5 MHz	707.5 MHz	713.5 MHz		



Report No.: SZEM180700654901 Page: 15 of 36

		RX	Channel 5035	Channel 5095	Channel 5155
		ΓΛ	731.5 MHz	737.5 MHz	743.5 MHz
	10MHz	ту	Channel 23060	Channel 23095	Channel 23130
		ТХ	704 MHz	707.5 MHz	711 MHz
			Channel 5060	Channel 5095	Channel 5130
		RX	734 MHz	737.5 MHz	741 MHz

Test Mode	Bandwidth	TX / RX	RF Channel		
Test Mode	Danuwiutii		Low (L)	Middle (M)	High (H)
		тх	Channel 23755	Channel 23790	Channel 23825
	5MHz		706.5 MHz	710 MHz	713.5 MHz
	510112	RX	Channel 5755	Channel 5790	Channel 5825
LTE BAND 17			736.5 MHz	740 MHz	743.5 MHz
		TX	Channel 23780	Channel 23790	Channel 23800
	10MHz -		709 MHz	710 MHz	711 MHz
		RX	Channel 5780	Channel 5790	Channel 5800
			739 MHz	740 MHz	741 MHz

TestMade	Denduridth			RF Channel	
Test Mode	Bandwidth	TX / RX	Low (L)	Middle (M)	High (H)
		ТХ	Channel 26697	Channel 26740	Channel 26783
	1.4MHz		814.7 MHz	819 MHz	823.3 MHz
	I.4IVI⊓Z	RX	Channel 8697	Channel 8740	Channel 8783
		ΓA	859.7 MHz	864MHz	868.3 MHz
		ТХ	Channel 26705	Channel 26740	Channel 26775
	3MHz	IX	815.5 MHz	819 MHz	822.5 MHz
		RX	Channel 8705	Channel 8740	Channel 8775
LTE BAND26			860.5 MHz	864MHz	867.5 MHz
(814-824)		ТХ	Channel 26715	Channel 26740	Channel 26765
	5MHz		816.5 MHz	819 MHz	821.5 MHz
		RX	Channel 8715	Channel 8740	Channel 8755
			861.5 MHz	864MHz	866.5 MHz
		ТХ	Channel 26740	Channel 26740	Channel 26740
	401411		819 MHz	819 MHz	819 MHz
	10MHz	DY	Channel 8740	Channel 8740	Channel 8740
		RX	864MHz	864MHz	864MHz



Report No.: SZEM180700654901 Page: 16 of 36

Test Mode	Bandwidth	TX / RX		RF Channel	
Test Mode	Danuwiutri	IA/KA	Low (L)	Middle (M)	High (H)
		ТХ	Channel 26797	Channel 26915	Channel 27033
	1.4MHz		824.7 MHz	836.5 MHz	848.3 MHz
	T.4IVI⊓Z	RX	Channel 8697	Channel 8915	Channel 9033
		ΓA	859.7 MHz	881.5 MHz	893.3 MHz
		ТХ	Channel 26805	Channel 26915	Channel 27025
	3MHz		825.5 MHz	836.5 MHz	847.5 MHz
	SIVIEZ	RX	Channel 8805	Channel 8915	Channel 9025
		RX	860.5 MHz	881.5 MHz	892.5 MHz
	5MHz	тх	Channel 26815	Channel 26915	Channel 27015
LTE BAND26			826.5 MHz	836.5 MHz	846.5 MHz
(824-849)		RX	Channel 8815	Channel 8915	Channel 9015
			871.5 MHz	881.5 MHz	891.5 MHz
		ТХ	Channel 26840	Channel 26915	Channel 26990
	10MHz		829 MHz	836.5 MHz	844 MHz
		RX	Channel 8840	Channel 8915	Channel 8990
		ΓA	874 MHz	881.5 MHz	889 MHz
		ТХ	Channel 26865	Channel 26915	Channel 26965
			831.5 MHz	836.5 MHz	841.5 MHz
	15MHz	RX	Channel 8865	Channel 8915	Channel 8965
			876.5 MHz	881.5 MHz	886.5 MHz

Test Mode	Bandwidth	TX / RX		RF Channel	
Test Mode	Danuwiutii		Low (L)	Middle (M)	High (H)
	5MHz	TX/RX	Channel 37775	Channel38000	Channel 38225
			2572.5 MHz	2595 MHz	2617.5 MHz
	10MHz	TX/RX	Channel 37800	Channel38000	Channel 38200
LTE BAND 38			2575 MHz	2595 MHz	2615 MHz
LIE DAND 30	15MHz	TX/RX	Channel 37825	Channel38000	Channel 38175
			2577.5 MHz	2595 MHz	2612.5 MHz
	20MHz	TX/RX	Channel 37850	Channel38000	Channel 38150
			2580 MHz	2595 MHz	2610 MHz



Report No.: SZEM180700654901 Page: 17 of 36

Test Mode	Bandwidth	TX / RX	RF Channel				
Test Mode	Danuwiuun		Low (L)	Middle (M)	High (H)		
	5MHz		Channel 39675	Channel40620	Channel 41565		
		TX/RX	2498.5 MHz	2593 MHz	2687.5 MHz		
	10MHz	TX/RX	Channel 39700	Channel40620	Channel 41540		
LTE BAND 41			2501 MHz	2593 MHz	2685 MHz		
LIE BAND 41	15MHz	TX/RX	Channel 39725	Channel40620	Channel 41515		
			2503.5 MHz	2593 MHz	2682.5 MHz		
	20MHz	TX/RX	Channel 39750	Channel40620	Channel 41490		
			2506 MHz	2593 MHz	2680 MHz		

Test frequencies for CA_5B

Table 4.3.1.1.5A-1: Test frequencies for CA_5B

Range	CC-Combo / NRB_agg [RB]		CC1 Note1					CC2 Note1				
		BW [RB]	NUL	fu∟ [MHz]	NDL	fol [MHz]	BW [RB]	Nul	fuL [MHz]	NDL	f _{DL} [MHz]	
Low	15+25	15	20416	825.6	2416	870.6	25	20455	829.5	2455	874.5	
		25	20425	826.5	2425	871.5	15	20464	830.4	2464	875.4	
	25+50	25	20428	826.8	2428	871.8	50	20500	834	2500	879	
	50+25	50	20450	829	2450	874	25	20522	836.2	2522	881.2	
	50+50	50	20450	829	2450	874	50	20549	838.9	2549	883.9	
Mid	15+25	15	20501	834.1	2501	879.1	25	20540	838.0	2540	883.0	
		25	20510	835.0	2510	880.0	15	20549	838.9	2549	883.9	
	25+50	25	20478	831.8	2478	876.8	50	20550	839	2550	884	
	50+25	50	20500	834	2500	879	25	20572	841.2	2572	886.2	
	50+50	50	20476	831.6	2476	876.6	50	20575	841.5	2575	886.5	
High	15+25	15	20586	842.6	2586	887.6	25	20625	846.5	2625	891.5	
<u> </u>		25	20595	843.5	2595	888.5	15	20634	847.4	2634	892.4	
	25+50	25	20528	836.8	2528	881.8	50	20600	844	2600	889	
	50+25	50	20550	839	2550	884	25	20622	846.2	2622	891.2	
	50+50	50	20501	834.1	2501	879.1	50	20600	844	2600	889	



Report No.: SZEM180700654901 Page: 18 of 36

Range	CC-Combo / NRB_agg CC1 [RB] Note1						CC2 Note1				
8		BW [RB]	NUL	fu∟ [MHz]	NDL	f _{DL} [MHz]	BW [RB]	NuL	fu∟ [MHz]	NDL	f _{DL} [MHz]
Low	50+100	50	20805	2505.5	2805	2625.5	100	20949	2519.9	2949	2639.9
	1	100	20850	2510	2850	2630	50	20994	2524.4	2994	2644.4
5	75+50	75	20825	2507.5	2825	2627.5	50	20945	2519.5	2945	2639.5
1	75+75	75	20825	2507.5	2825	2627.5	75	20975	2522.5	2975	2642.5
ŝ	75+100	75	20828	2507.8	2828	2627.8	100	20999	2524.9	2999	2644.9
		100	20850	2510	2850	2630	75	21021	2527.1	3021	2647.1
1	100+100	100	20850	2510	2850	2630	100	21048	2529.8	3048	2649.8
Mid	50+100	50	21006	2525.6	3006	2645.6	100	21150	2540	3150	2660
		100	21051	2530.1	3051	2650.1	50	21195	2544.5	3195	2664.5
	75+50	75	21051	2530.1	3051	2650.1	50	21171	2542.1	3171	2662.1
	75+75	75	21025	2527.5	3025	2647.5	75	21175	2542.5	3175	2662.5
*	75+100	75	21003	2525.3	3003	2645.3	100	21174	2542.4	3174	2662.4
	1	100	21026	2527.6	3026	2647.6	75	21197	2544.7	3197	2664.7
	100+100	100	21001	2525.1	3001	2645.1	100	21199	2544.9	3199	2664.9
High	50+100	50	21206	2545.6	3206	2665.6	100	21350	2560	3350	2680
0.0500		100	21251	2550.1	3251	2670.1	50	21395	2564.5	3395	2684.5
	75+50	75	21277	2552.7	3277	2672.7	50	21397	2564.7	3397	2684.7
1- 1	75+75	75	21225	2547.5	3225	2667.5	75	21375	2562.5	3375	2682.5
	75+100	75	21179	2542.9	3179	2662.9	100	21350	2560	3350	2680
	l l	100	21201	2545.1	3201	2665.1	75	21372	2562.2	3372	2682.2
8	100+100	100	21152	2540.2	3152	2660.2	100	21350	2560	3350	2680

Test frequencies for CA_7C

Table 4.3.1.1.7A-1: Test frequencies for CA_7C

Note 1: Carriers in increasing frequency order.

Test frequencies for CA_38C

Table 4.3.1.2.6A-1: Test frequencies for CA_38C

Range	CC- Combo / NRB_agg [RB]		CC1 Note1			CC2 Note1	
12		BW [RB]	NUL/DL	ful/dl [MHz]	BW [RB]	NUL/DL	ful/dl [MHz]
Low	75+75	75	37825	2577.5	75	37975	2592.5
	100+100	100	37850	2580	100	38048	2599.8
Mid	75+75	75	37925	2587.5	75	38075	2602.5
	100+100	100	37901	2585.1	100	38099	2604.9
High	75+75	75	38025	2597.5	75	38175	2612.5
	100+100	100	37952	2590.2	100	38150	2610

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.sgx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions.Terms-en-Document.aspx Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction document. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 19 of 36

Range	Range	CC- Combo / NRB_agg [RB]		CC1 Note1		1	CC2 Note1	
-1010-03 - 04-5		BW [RB]	NUL/DL	ful/dl [MHz]	BW [RB]	NUL/DL	ful/dl [MHz]	
Low	25+100	25	39683	2499.3	100	39800	2511	
		100	39750	2506	25	39867	2517.7	
	50+75	50	39703	2501.3	75	39823	2513.3	
		75	39725	2503.5	50	39845	2515.5	
	50+100	50	39705	2501.5	100	39849	2515.9	
		100	39750	2506	50	39894	2520.4	
	75+75	75	39725	2503.5	75	39875	2518.5	
	75+100	75	39728	2503.8	100	39899	2520.9	
		100	39750	2506	75	39921	2523.1	
	100+100	100	39750	2506	100	39948	2525.8	
Mid	25+100	25	40528	2583.8	100	40645	2595.5	
		100	40595	2590.5	25	40712	2602.2	
	50+75	50	40549	2585.9	75	40669	2597.9	
		75	40571	2588.1	50	40691	2600.1	
	50+100	50	40526	2583.6	100	40670	2598.0	
		100	40571	2588.1	50	40715	2602.5	
	75+75	75	40545	2585.5	75	40695	2600.5	
	75+100	75	40523	2583.3	100	40694	2600.4	
		100	40546	2585.6	75	40717	2602.7	
	100+100	100	40521	2583.1	100	40719	2602.9	
High	25+100	25	41373	2668.3	100	41490	2680	
25		100	41440	2675	25	41557	2686.7	
	50+75	50	41395	2670.5	75	41515	2682.5	
		75	41417	2672.7	50	41537	2684.7	
	50+100	50	41346	2665.6	100	41490	2680	
		100	41391	2670.1	50	41535	2684.5	
	75+75	75	41365	2667.5	75	41515	2682.5	
	75+100	75	41319	2662.9	100	41490	2680	
		100	41341	2665.1	75	41512	2682.2	
	100+100	100	41292	2660.2	100	41490	2680	

Test frequencies for CA_41C Table 4.3.1.2.9A-1: Test frequencies for CA_41C

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-en-Document.aspx, Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 20 of 36

3.6 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

3.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC –Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

3.8 Deviation from Standards

None.

3.9 Abnormalities from Standard Conditions

None.



Report No.: SZEM180700654901 Page: 21 of 36

3.10Other Information Requested by the Customer

None.

3.11 Technical Specification

Characteristi	ics	Description	
		GSM	
Radio Syster	т Туре	UMTS	
		🛛 LTE	
		0014050	Transmission (TX):824 to 849 MHz
	GSM850	Receiving (RX):869 to 894 MHz	
		00144000	Transmission (TX):1850 to 1910 MHz
		GSM1900	Receiving (RX): 1930 to 1990 MHz
			Transmission (TX):1850 to 1910 MHz
		UMTS BAND II	Receiving (RX):1930 to 1990 MHz
			Transmission (TX):1710 to 1755 MHz
		UMTS BAND IV	Receiving (RX): 2110 to 2155 MHz
			Transmission (TX):824 to 849 MHz
		UMTS BAND V	Receiving (RX):869 to 894 MHz
			Transmission (TX):1850 to 1910 MHz
		LTE BAND 2	Receiving (RX):1930 to 1990 MHz
		LTE BAND 4	Transmission (TX):1710 to 1755 MHz
			Receiving (RX): 2110 to 2155 MHz
		LTE BAND 5	Transmission (TX): 824 to 849 MHz
Supported	Frequency		Receiving (RX): 869 to 894 MHz
Range		LTE BAND 7	Transmission (TX): 2500 to 2570 MHz
			Receiving (RX): 2620 to 2690 MHz
		LTE BAND 12	Transmission (TX):699 to 716 MHz
			Receiving (RX): 729 to 746 MHz
		LTE BAND 17	Transmission (TX):704 to 716 MHz
			Receiving (RX): 734 to 746 MHz
		LTE BAND 26	Transmission (TX): 814 to 824MHz
		(814 to 824 MHz)	Receiving (RX): 859 to 869 MHz
		LTE BAND 26	Transmission (TX):824 to 849 MHz
		(824 to 849 MHz)	Receiving (RX):869 to 894 MHz
		LTE BAND 38	Transmission (TX):2570 to 2620 MHz
			Receiving (RX): 2570 to 2620 MHz
			Transmission (TX):2496 to 2690MHz
		LTE BAND 41	Receiving (RX): 2496 to 2690MHz
			Transmission (TX): 824 to 849 MHz
		LTE CA_5B	Receiving (RX): 869 to 894 MHz

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-en-Document.aspx, Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 22 of 36

		Transmission (TX): 2500 to 2570 MHz					
	LTE CA_7C	Receiving (RX):2620 to 2690 MHz					
		Transmission (TX): 2570 to 2620 MHz					
	LTE CA_38C	Receiving (RX): 2570 to 2620 MHz					
		Transmission (TX):2496 to 2690MHz					
	LTE CA_41C						
	GSM850:33 dBm	Receiving (RX): 2496 to 2690MHz					
	GSM1900: 30dBm						
	UMTS BAND II: 23dBm UMTS BAND IV: 23dBm						
	UMTS BAND V: 23dBm						
	LTE BAND 2: 25dBm						
	LTE BAND 4: 25.2dBm						
	LTE BAND 5: 25.5dBm						
Target TX Output Power	LTE BAND 7: 24.7dBm						
	LTE BAND12: 25.5dBm						
	LTE BAND17: 25.5dBm						
	LTE BAND26: 25.5dBm LTE BAND38: 25.2dBm						
	LTE BAND36. 25.20Bm						
	LTE BAND 41. 25.20Bm						
	_						
	LTE BAND CA_7C: 24.7dBm						
	LTE BAND CA_38C: 25.2dBm						
	LTE BAND CA_41C: 25.2dBm						
	GSM system:	⊠0.2 MHz					
	UMTS system:	⊠5 MHz					
	LTE BAND 2	⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz; ⊠15 MHz, ⊠20 MHz					
	LTE BAND 4	⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz; ⊠15 MHz, ⊠20 MHz					
	LTE BAND 5	⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz					
	LTE BAND 7	⊠5 MHz; ⊠10 MHz; ⊠15 MHz, ⊠20 MHz					
Supported Channel	LTE BAND 12	⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz					
Bandwidth	LTE BAND 17	⊠5 MHz; ⊠10 MHz					
	LTE BAND 26						
	(814-824)	⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz;					
	LTE BAND 26						
	(824-849)	⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz; ⊠15 MHz					
	LTE BAND38	⊠5 MHz; ⊠10 MHz; ⊠15 MHz, ⊠20 MHz					
	LTE BAND41	⊠5 MHz; ⊠10 MHz; ⊠15 MHz, ⊠20 MHz					
	LTE BAND CA_5B						
	LTE BAND CA 7C	⊠50+100; ⊠75+50; ⊠75+75, ⊠75+100					
This desument is issued by the Common subj	–	verleaf, available on request or accessible at <u>http://www.sgs.com/en/Terms-and-Conditions.aspx</u> and,					

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions/Terms-en-Document.aspx. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unatorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 23 of 36

		⊠100+100
	LTE BAND CA_38C	
	LTE BAND CA_41C	∑25+100;∑50+75; ∑50+100; ∑75+75; ∑75+100, ∑100+100
Characteristics	Description	
	GSM850	246KGXW,256KG7W
	GSM1900	243KGXW,253KG7W
	UMTS BAND II	4M17F9W
	UMTS BAND IV	4M17F9W
	UMTS BAND V	4M17F9W
		1M10G7D;1M10W7D; 1M10W7D
		2M70G7D;2M70W7D; 2M70W7D
		4M48G7D;4M48W7D; 4M48W7D
	LTE BAND 2	8M93G7D;8M95W7D; 8M93W7D
		13M5G7D;13M5W7D; 13M5W7D
		17M9G7D;18M0W7D; 17M9W7D
		1M10G7D;1M09W7D; 1M10W7D
		2M70G7D;2M70W7D; 2M70W7D
		4M48G7D;4M49W7D; 4M49W7D
Designation of	LTE BAND 4	8M95G7D;8M95W7D; 8M97W7D
Emissions		13M5G7D;13M5W7D; 13M5W7D
(Note: the necessary		17M9G7D;17M9W7D; 17M9W7D
bandwidth of which is		1M10G7D;1M09W7D; 1M09W7D
the worst value from the		2M70G7D;2M70W7D; 2M70W7D
measured occupied bandwidths for each	LTE BAND 5	4M48G7D;4M49W7D; 4M48W7D
type of channel		8M95G7D;8M95W7D; 8M95W7D
bandwidth		4M48G7D;4M48W7D; 4M48W7D
configuration.)		8M95G7D;8M95W7D; 8M95W7D
	LTE BAND 7	13M5G7D;13M5W7D; 13M5W7D
		17M9G7D;17M9W7D; 18M0W7D
		1M10G7D;1M09W7D; 1M09W7D
	LTE BAND 12	2M70G7D;2M70W7D; 2M70W7D
		4M49G7D;4M48W7D; 4M48W7D
		8M95G7D;8M95W7D; 8M95W7D
	LTE BAND 17	4M50G7D;4M49W7D; 4M48W7D
		8M95G7D;8M95W7D; 8M93W7D
		1M10G7D;1M10W7D; 1M10W7D
	LTE BAND 26	2M70G7D;2M70W7D; 2M70W7D
	(814-824)	4M48G7D;4M49W7D; 4M48W7D
		8M95G7D;8M95W7D; 8M95W7D
	LTE BAND 26	1M10G7D;1M10W7D; 1M09W7D
	(824-849)	2M69G7D;2M70W7D; 2M70W7D



Report No.: SZEM180700654901 Page: 24 of 36

		1
		4M49G7D;4M48W7D; 4M48W7D
		8M95G7D;8M95W7D; 8M95W7D
		13M5G7D;13M5W7D; 13M5W7D
		4M49G7D;4M48W7D; 4M48W7D
		8M95G7D;8M95W7D; 8M95W7D
	LTE BAND 38	13M5G7D;13M5W7D; 13M5W7D
		18M0G7D;17M9W7D; 17M9W7D
		4M48G7D;4M47W7D; 4M48W7D
	LTE BAND 41	8M91G7D;8M95W7D; 8M95W7D
		13M5G7D;13M5W7D; 13M5W7D
		17M9G7D;18M0W7D; 17M9W7D
		14M0G7D;14M0W7D; 13M9W7D
	LTE BAND CA_5B	18M8G7D;18M8W7D; 18M9W7D
		28M4G7D;28M3W7D; 28M3W7D
	LTE BAND CA_7C	37M6G7D;37M6W7D; 37M6W7D
		28M3G7D;28M4W7D; 28M4W7D
	LTE BAND CA_38C	37M5G7D;37M6W7D; 37M6W7D
		22M9G7D;22M9W7D; 22M9W7D
	LTE BAND CA_41C	37M6G7D;37M6W7D; 37M6W7D

4 Description of Tests

4.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 V03r01

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Note: Reference test setup 1

4.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 V03r01 ; ANSI/TIA-603-E-2016-Section 2.2.17

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 0.8m high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions/Terms-e-Document.aspx. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgrey or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 25 of 36

- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8). Calculate power in dBm by the following formula:

ERP (dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBd)

Where:

Pg is the generator output power into the substitution antenna.

Above 1GHz test procedure as below:

- 1). Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2). Calculate power in dBm by the following formula:

EIRP(dBm) = Pg(dBm) - cable loss (dB) + antenna gain (dBi)

EIRP=ERP+2.15dB

Where:

Pg is the generator output power into the substitution antenna.

- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete. Note: Reference test setup 2

4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel). The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.



Report No.: SZEM180700654901 Page: 26 of 36

Note: Reference test setup 1

Test Settings

- The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5% of the expected OBW
- VBW ≥ 3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- 7. The trace was allowed to stabilize
- 8. If necessary, steps 2 7 were repeated after changing the RBW such that it would be within

1 - 5% of the 99% occupied bandwidth observed in Step 7

4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to peak or peak hold power.

Note: Reference test setup 1

Test Settings

- 1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
- 2. Span was set large enough so as to capture all out of band emissions near the band edge
- 3. RBW > 1% of the emission bandwidth
- 4. $VBW \ge 3 \times RBW$
- 5. Detector = RMS
- 6. Number of sweep points ≥ 2 x Span/RBW
- 7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
- 8. Sweep time = auto couple
- 9. The trace was allowed to stabilize

4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel



Report No.: SZEM180700654901 Page: 27 of 36

and high channel). The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1

Test Settings

- Start frequency was set to 30MHz and stop frequency was set to at least 10 * the fundamental frequency (separated into at least two plots per channel)
- 2 Detector = RMS
- 3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
- 4. Sweep time = auto couple
- 5. The trace was allowed to stabilize
- 6. Please see test notes below for RBW and VBW settings

4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.1

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1

Test Settings

- 1. The signal analyzer's CCDF measurement profile is enabled
- 2. Frequency = carrier center frequency
- 3. Measurement BW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- 5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01

Below 1GHz test procedure as below:



Report No.: SZEM180700654901 Page: 28 of 36

- 1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8) Calculate power in dBm by the following formula:

ERP(dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBd)

Where:

Pd is the dipole equivalent power, Pg is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB]. The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log10(Power [Watts]).

Above 1GHz test procedure as below:

1) Different between above is the test site, change from Semi- Anechoic

Chamber to fully Anechoic Chamber

2) Calculate power in dBm by the following formula:

EIRP(dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBi)

EIRP=ERP+2.15dB

Where:

Pg is the generator output power into the substitution antenna.

- 3. Test the EUT in the lowest channel, the middle channel the Highest channel
- 4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5. Repeat above procedures until all frequencies measured was complete

Note: Reference test setup 3

4.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; ANSI/TIA-603-E-2016

. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment,

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.sgp and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions.sgp and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-and-Conditions/Terms-en-Document.aspx. Attention is drawn to the limitation only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exoented parties to a transaction form exercising all their rights and obligations under the transaction document. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 29 of 36

primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Time Period and Procedure:

- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

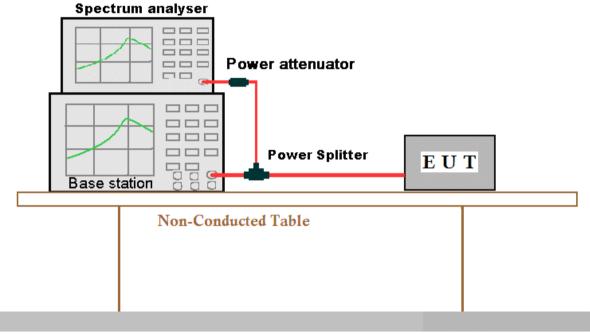
Note: Reference test setup 4



Report No.: SZEM180700654901 Page: 30 of 36

4.9 Test Setups

Test Setup 1



Ground Reference Plane

Test Setup 2

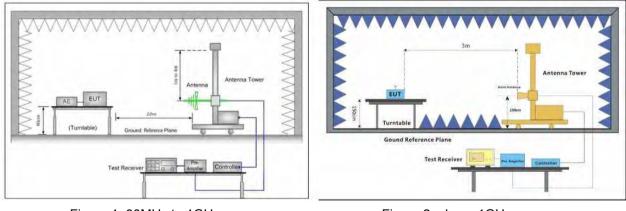


Figure 1. 30MHz to 1GHz

Figure 2. above 1GHz



Report No.: SZEM180700654901 Page: 31 of 36

Test Setup 3

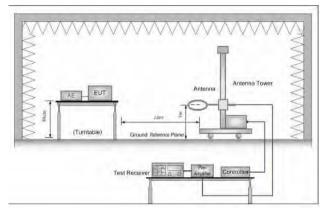


Figure 1. Below 30MHz

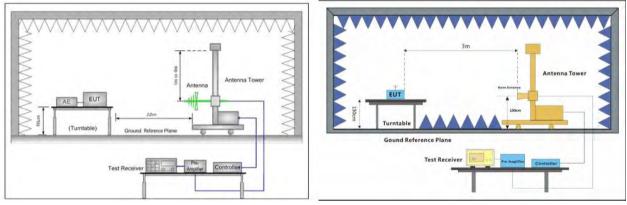
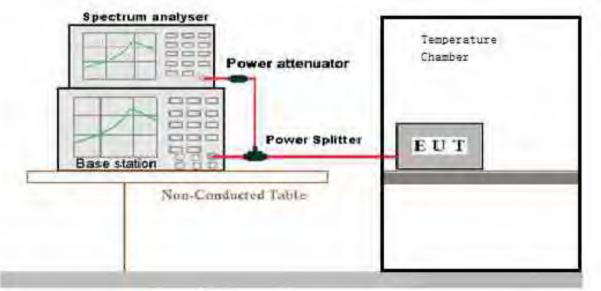


Figure 2. 30MHz to 1GHz

Figure 3. above 1GHz

Test Setup 4



Ground Reference Plane

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions.aspx and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at http://www.sgs.com/en/Terms-en-Document.aspx, Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falisfication of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.



Report No.: SZEM180700654901 Page: 32 of 36

4.10 Test Conditions

		Test Conditions				
		Test Environment	Ambient Climate & Rated Voltage			
	Average	Test Setup	Test Setup 1			
	Power, Total	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Transmit		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;			
Output			UMTS/TM2; LTE/TM1;LTE/TM2; LTE/TM3			
Power Data	Average	Test Environment	Ambient Climate & Rated Voltage			
-	Average Power,	Test Setup	Test Setup 1			
:	Spectral Density (if	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
	required)	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; TM1;LTE/TM1;LTE/TM2; LTE/TM3			
ľ		Test Environment	Ambient Climate & Rated Voltage			
		Test Setup	Test Setup 1			
Peak-to-Average Ratio (if required)		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; TM1;LTE/TM1;LTE/TM2; LTE/TM3			
		Test Environment	Ambient Climate & Rated Voltage			
		Test Setup 1				
Modulation Characteristic	cs	RF Channels (TX)	M (M= middle channel)			
Characteriotic		Toot Mada	GSM/TM1;GSM/TM2;UMTS/TM1;			
		Test Mode	UMTS/TM2; LTE/TM1;LTE/TM2; LTE/TM3			
		Test Environment	Ambient Climate & Rated Voltage			
		Test Setup	Test Setup 1			
	Occupied Bandwidth	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;			
Bandwidth			UMTS/TM2; LTE/TM1;LTE/TM2; LTE/TM3			
		Test Environment	Ambient Climate & Rated Voltage			
	Emission	Test Setup	Test Setup 1			
	Bandwidth (if	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
1	required)	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;			
			UMTS/TM2; LTE/TM1;LTE/TM2; LTE/TM3			
Band Edges		Test Environment	Ambient Climate & Rated Voltage			
Band Edges Compliance		Test Setup	Test Setup 1			
		RF Channels (TX)	L, H (L= low channel, H= high channel)			



Report No.: SZEM180700654901 Page: 33 of 36

		1				
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;				
		UMTS/TM2; LTE/TM1;LTE/TM2 ; LTE/TM3				
	Test Environment	Ambient Climate & Rated Voltage				
Spurious Emission at	Test Setup	Test Setup 1				
Antenna Terminals	RF Channels (TX)	L,M, H				
		(L= low channel, M= middle channel, H= high channel)				
	Test Mode	GSM/TM1;UMTS/TM1; LTE/TM1				
	Test Environment	Ambient Climate & Rated Voltage				
	Test Setup	Test Setup 2				
Field Strength of		GSM/TM1;GSM/TM2;UMTS/TM1;UMTS/TM2; LTE/TM1;LTE/TM2; LTE/TM3				
Spurious Radiation	Test Mode	NOTE: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected.				
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)				
	Test Environment	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;				
		(2) VL, VN and VH of Rated Voltage at Ambient Climate.				
	Test Setup	Test Setup 4				
Frequency Stability	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)				
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;				
		UMTS/TM2; LTE/TM1;LTE/TM2; LTE/TM3				



Report No.: SZEM180700654901 Page: 34 of 36

		RE	E in Chamber			
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEM001-01	2018/03/13	2021/03/12
2	3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/03/13	2021/03/12
3	EMI Test Receiver	Agilent Technologies	N9038A	SEM004-05	2017/10/09	2018/10/09
4	EXA Signal Analyzer (10Hz- 26.5GHz)	Agilent Technologies Inc	N9010A	SEM004-09	2018/04/13	2019/04/12
5	BiConiLog Antenna (26-3000MHz)	ETS-LINDGREN	3142C	SEM003-02	201711/15	2020/11/15
6	Double-ridged horn (1-18GHz)	ETS-LINDGREN	3117	SEM003-11	2015/10/17	2018/10/17
7	Horn Antenna (18- 26GHz)	ETS-LINDGREN	3160	SEM003-12	2017/11/24	2020/11/24
8	Horn Antenna (15GHz-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2017/10/17	2020/10/17
9	Low Noise Amplifier (100MHz-18GHz)	Black Diamond Series	BDLNA- 0118- 352810	SEM005-05	2017/09/27	2018/09/26
10	Band filter	N/A	N/A	N/A	N/A	N/A
11	Pre-amplifier (0.1- 1300MHz)	Agilent Technologies	8447D	SEM005-01	2018/03/13	2019/03/12
12	Pre-Amplifier (0.1- 26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	SEM004-10	2017/10/17	2018/10/17
13	Pre-amplifier (26GHz-40GHz)	Compliance Directions Systems Inc.	PAP-2640- 50	SEM005-08	2018/03/14	2019/03/14
14	Band filter	Amindeon	82346	SEM023-01	N/A	N/A
15	Universal radio communication tester	Rohde &Schwarz	CMU200	SEM010-01	2017/10/09	2018/10/09
16	Universal radio communication tester	Rohde &Schwarz	CMW500	SEM010-03	2017/10/23	2018/10/23
17	DC Power Supply	Zhao Xin	RXN-305D	SEM011-02	2017/10/09	2018/10/09
18	BiConiLog Antenna (30MHz-3GHz)	Schwarzbeck	VULB9163	SEM003-05	2015/10/17	2018/10/17
19	Horn Antenna (800MHz-18GHz)	Rohde &Schwarz	HF907	SEM003-06	2018/06/06	2021/06/06

5 Main Test Instruments



Report No.: SZEM180700654901 Page: 35 of 36

RE in Chamber								
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy mm-dd)	Cal. Due date (yyyy-mm-dd)		
1	10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2018/03/10	2019/03/09		
2	EMI Test Receiver (9k-7GHz)	Rohde & Schwarz	ESR	SEM004-03	2018/02/14	2019/02/14		
3	Trilog-Broadband Antenna(30M-1GHz)	Schwarzbeck	VULB9168	SEM003-18	2016/06/29	2019/06/29		
4	Pre-amplifier	Sonoma Instrument Co	310N	SEM005-03	2018/06/06	2019/06/05		
5	.Loop Antenna	ETS-Lindgren	6502	SEM003-08	2018/07/14	2021/07/13		

RF connected test							
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)	
1	Humi/ Temp Indicator	MingGao	TH101B	W006-09	2018/03/13	2019/03/12	
2	Signal Analyzer	Rohde Schwarz	FSV	W025-02	2018/03/13	2019/03/12	
3	Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2018/04/14	2019/04/13	
4	Barometer	ChangChun	DYM3	SEL0088	2018/05/24	2019/05/24	
5	Dual Output Mobile Communication DC Source	Agilent Technologies Inc	66311B	W009-09	2018/04/28	2019/04/28	
6	Digital Multimeter	Fluke	15B+	W055-01	2018/03/13	2019/03/12	
7	Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	W005-02	2018/03/13	2019/03/12	
8	Temperature Chamber	GIANT FORCE	ICT-150-40- CP-AR	W027-04	2017/12/04	2018/12/04	
9	Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2018/05/02	2019/05/01	



Report No.: SZEM180700654901 Page: 36 of 36

6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	Data		
Transmit Output Power Data	Power [dBm]	U =±0.37 dB		
Bandwidth	Magnitude [%]	U =± 0.2%		
Band Edge Compliance	Disturbance Power [dBm]	U = ±2.0 dB		
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = ±2.0 dB		
		For 3 m Chamber:		
		U = ±4.5 dB (30 MHz to 1GHz)		
Field Strength of Spurious		U = ± 3.3 dB (above 1 GHz)		
Radiation	ERP[dBm]/EIRP [dBm]	For 10 m Chamber:		
		U = ±4.5 dB (30 MHz to 1GHz)		
		$U = \pm 3.2 \text{ dB}$ (above 1 GHz)		
Frequency Stability	Frequency Accuracy [ppm]	U = ±0.24 ppm		

7 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1807006549RG.

The End